

**Quad SPST CMOS Analog Switches****Features**

- Low On-Resistance:  $50\ \Omega$
- Low Leakage:  $80\ pA$
- Low Power Consumption:  $22\ nW$
- Fast Switching Action— $t_{ON}$ :  $120\ ns$
- Low Charge Injection
- DG211/DG212 Upgrades
- TTL/CMOS Logic Compatible

**Benefits**

- Low Signal Errors and Distortion
- Reduced Power Supply Requirements
- Faster Throughput
- Improved Reliability
- Reduced Pedestal Errors
- Simple Interfacing

**Applications**

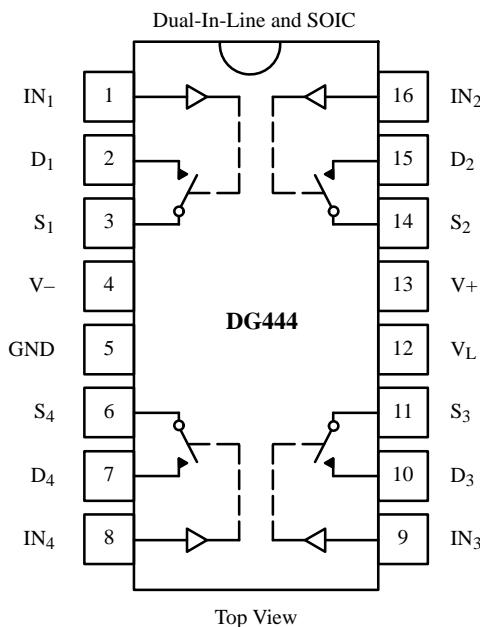
- Audio Switching
- Battery Powered Systems
- Data Acquisition
- Sample-and-Hold Circuits
- Telecommunication Systems
- Automatic Test Equipment
- Single Supply Circuits
- Hard Disk Drives

**Description**

The DG444/DG445 monolithic quad analog switches are designed to provide high speed, low error switching of analog signals. The DG444 has a normally closed function. The DG445 has a normally open function. Combining low power ( $22\ nW$ , typ) with high speed ( $t_{ON}$ :  $120\ ns$ , typ), the DG444/DG445 are ideally suited for upgrading DG211/212 sockets. Charge injection has been minimized on the drain for use in sample-and-hold circuits.

To achieve high-voltage ratings and superior switching performance, the DG444/DG445 are built on Siliconix's high-voltage silicon-gate process. An epitaxial layer prevents latchup.

Each switch conducts equally well in both directions when on, and blocks input voltages to the supply levels when off.

**Functional Block Diagram and Pin Configuration****Truth Table**

Logic	DG444	DG445
0	ON	OFF
1	OFF	ON

Logic "0"  $\leq 0.8\ V$ , Logic "1"  $\geq 2.4\ V$   
Switches Shown for Logic "0" Input

**Ordering Information**

Temp Range	Package	Part Number
$-40^{\circ}C$ to $85^{\circ}C$	16-Pin Plastic DIP	DG444DJ
		DG445DJ
	16-Pin Narrow SOIC	DG444DY
		DG445DY

## Absolute Maximum Ratings

V <sub>+</sub> to V <sub>-</sub>	.....	44 V	Power Dissipation (Package) <sup>b</sup>
GND to V <sub>-</sub>	.....	25 V	16-Pin Plastic DIP <sup>c</sup> ..... 450 mW
V <sub>L</sub>	.....	(GND -0.3 V) to (V <sub>+</sub> ) + 0.3 V	16-Pin Narrow Body SOIC <sup>d</sup> ..... 600 mW
Digital Inputs <sup>a</sup> V <sub>S</sub> , V <sub>D</sub>	.....	(V <sub>-</sub> ) -2 V to (V <sub>+</sub> ) +2 V or 30 mA, whichever occurs first	
Continuous Current (Any Terminal)	.....	30 mA	
Current, S or D (Pulsed 1 ms, 10% duty cycle)	.....	100 mA	
Storage Temperature	.....	-65 to 125°C	

### Notes:

- a. Signals on S<sub>X</sub>, D<sub>X</sub>, or I<sub>NX</sub> exceeding V<sub>+</sub> or V<sub>-</sub> will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
- b. All leads welded or soldered to PC Board.
- c. Derate 6 mW/°C above 75°C
- d. Derate 12 mW/°C above 75°C

## Specifications for Dual Supplies

Parameter	Symbol	Test Conditions Unless Otherwise Specified  V <sub>+</sub> = 15 V, V <sub>-</sub> = -15 V V <sub>L</sub> = 5 V, V <sub>IN</sub> = 2.4 V, 0.8 V <sup>e</sup>	Temp <sup>a</sup>	D Suffix -40 to 85°C			Unit
				Min <sup>c</sup>	Typ <sup>b</sup>	Max <sup>c</sup>	
<b>Analog Switch</b>							
Analog Signal Range <sup>d</sup>	V <sub>ANALOG</sub>		Full	-15		15	V
Drain-Source On-Resistance	r <sub>DS(on)</sub>	I <sub>S</sub> = -10 mA, V <sub>D</sub> = ±8.5 V V <sub>+</sub> = 13.5 V, V <sub>-</sub> = -13.5 V	Room Full		50	85 100	Ω
Switch Off Leakage Current	I <sub>S(off)</sub>	V <sub>+</sub> = 16.5, V <sub>-</sub> = -16.5 V V <sub>D</sub> = ±15.5 V, V <sub>S</sub> = ±15.5 V	Room Full	-0.5 -5	±0.01	0.5 5	nA
	I <sub>D(off)</sub>		Room Full	-0.5 -5	±0.01	0.5 5	
Channel On Leakage Current	I <sub>D(on)</sub>	V <sub>+</sub> = 16.5 V, V <sub>-</sub> = -16.5 V V <sub>S</sub> = V <sub>D</sub> = ±15.5 V	Room Full	-0.5 -10	±0.08	0.5 10	
<b>Digital Control</b>							
Input Current V <sub>IN</sub> Low	I <sub>IL</sub>	V <sub>IN</sub> under test = 0.8 V All Other = 2.4 V	Full	-500	-0.01	500	nA
Input Current V <sub>IN</sub> High	I <sub>IH</sub>	V <sub>IN</sub> under test = 2.4 V All Other = 0.8 V	Full	-500	0.01	500	
<b>Dynamic Characteristics</b>							
Turn-On Time	t <sub>ON</sub>	R <sub>L</sub> = 1 kΩ, C <sub>L</sub> = 35 pF V <sub>S</sub> = ±10 V, See Figure 2	Room		120	250	ns
Turn-Off Time	t <sub>OFF</sub>		DG444	Room		110	140
			DG445	Room		160	210
Charge Injection <sup>e</sup>	Q	C <sub>L</sub> = 1 nF, V <sub>S</sub> = 0 V V <sub>gen</sub> = 0 V, R <sub>gen</sub> = 0 Ω	Room		-1		pC
Off Isolation <sup>e</sup>	OIRR	R <sub>L</sub> = 50 Ω, C <sub>L</sub> = 5 pF, f = 1 MHz	Room		60		dB
Crosstalk (Channel-to-Channel) <sup>d</sup>	X <sub>TALK</sub>		Room		100		
Source Off Capacitance	C <sub>S(off)</sub>	f = 1 MHz	Room		4		pF
Drain Off Capacitance	C <sub>D(off)</sub>		Room		4		
Channel On Capacitance	C <sub>D(on)</sub>	V <sub>ANALOG</sub> = 0 V	Room		16		

## Specifications for Dual Supplies (Cont'd)

Parameter	Symbol	Test Conditions Unless Otherwise Specified $V_+ = 15 \text{ V}$ , $V_- = -15 \text{ V}$ $V_L = 5 \text{ V}$ , $V_{IN} = 2.4 \text{ V}$ , $0.8 \text{ V}^e$	Temp <sup>a</sup>	D Suffix -40 to 85°C			Unit
				Min <sup>c</sup>	Typ <sup>b</sup>	Max <sup>c</sup>	
<b>Power Supplies</b>							
Positive Supply Current	I <sub>+</sub>	$V_+ = 16.5 \text{ V}$ , $V_- = -16.5 \text{ V}$ $V_{IN} = 0$ or $5 \text{ V}$	Room Full		0.001	1 5	μA
Negative Supply Current	I <sub>-</sub>		Room Full	-1 -5	-0.0001		
Logic Supply Current	I <sub>L</sub>		Room Full		0.001	1 5	
Ground Current	I <sub>GND</sub>		Room Full	-1 -5	-0.001		

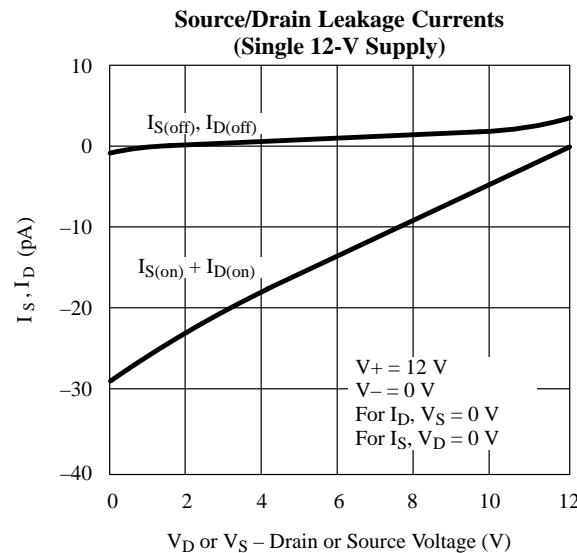
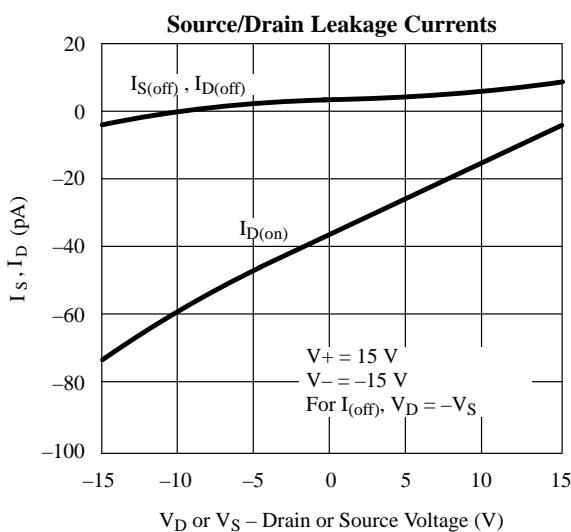
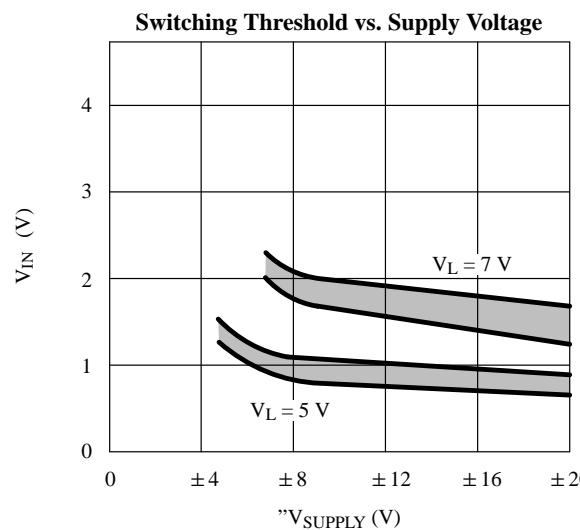
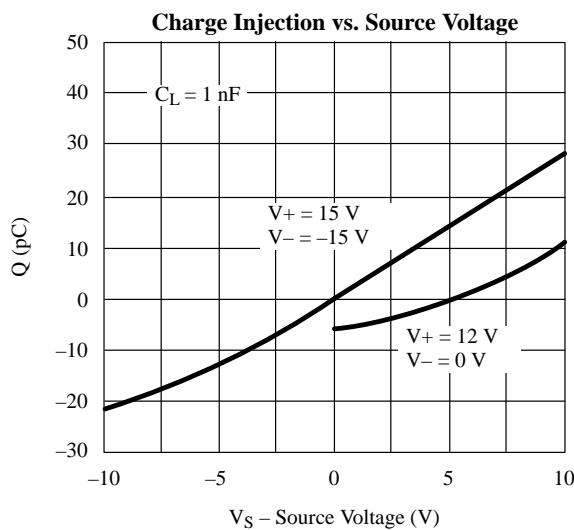
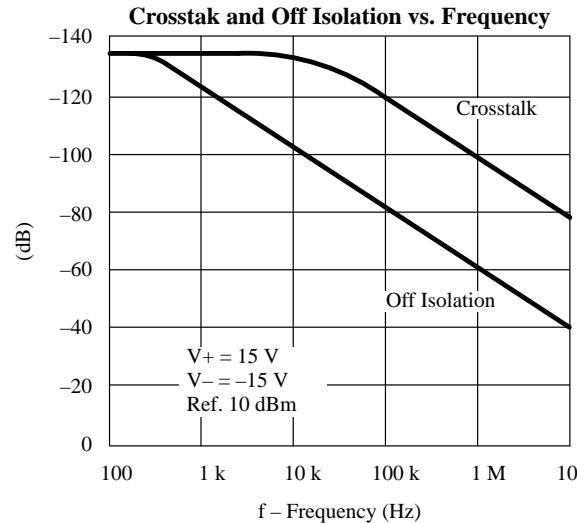
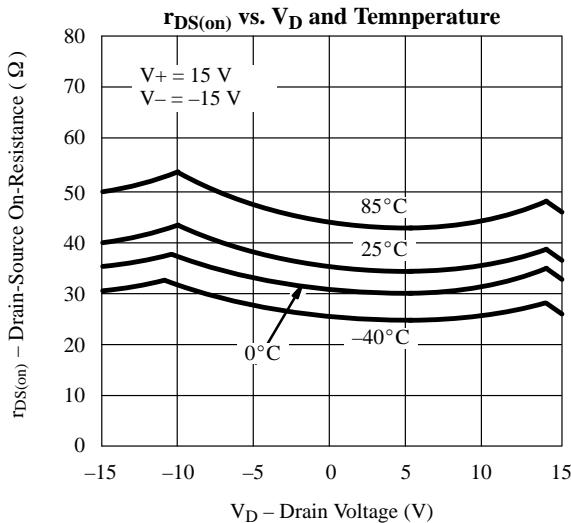
## Specifications for Unipolar Supplies

Parameter	Symbol	Test Conditions Unless Otherwise Specified $V_+ = 12 \text{ V}$ , $V_- = 0 \text{ V}$ $V_L = 5 \text{ V}$ , $V_{IN} = 2.4 \text{ V}$ , $0.8 \text{ V}^e$	Temp	D Suffix -40 to 85°C			Unit
				Min <sup>c</sup>	Typ <sup>b</sup>	Max <sup>c</sup>	
<b>Analog Switch</b>							
Analog Signal Range <sup>d</sup>	V <sub>ANALOG</sub>		Full	0		12	V
Drain-Source On-Resistance <sup>d</sup>	r <sub>DS(on)</sub>	I <sub>S</sub> = -10 mA, V <sub>D</sub> = 3 V, 8 V V <sub>+</sub> = 10.8 V, V <sub>L</sub> = 5.25 V	Room Full		100	160 200	Ω
<b>Dynamic Characteristics</b>							
Turn-On Time	t <sub>ON</sub>	R <sub>L</sub> = 1 kΩ, C <sub>L</sub> = 35 pF, V <sub>S</sub> = 8 V See Figure 2	Room		300	450	ns
Turn-Off Time	t <sub>OFF</sub>		Room		60	200	
Charge Injection	Q	C <sub>L</sub> = 1 nF, V <sub>gen</sub> = 6 V, R <sub>gen</sub> = 0 Ω	Room		2		pC
<b>Power Supplies</b>							
Positive Supply Current	I <sub>+</sub>	V <sub>+</sub> = 13.2 V, V <sub>IN</sub> = 0 or 5 V	Room Full		0.001	1 5	μA
Negative Supply Current	I <sub>-</sub>	V <sub>IN</sub> = 0 or 5 V	Room Full	-1 -5	-0.0001		
Logic Supply Current	I <sub>L</sub>	V <sub>L</sub> = 5.25 V, V <sub>IN</sub> = 0 or 5 V	Room Full		0.001	1 5	
Ground Current	I <sub>GND</sub>	V <sub>IN</sub> = 0 or 5 V	Room Full	-1 -5	-0.001		

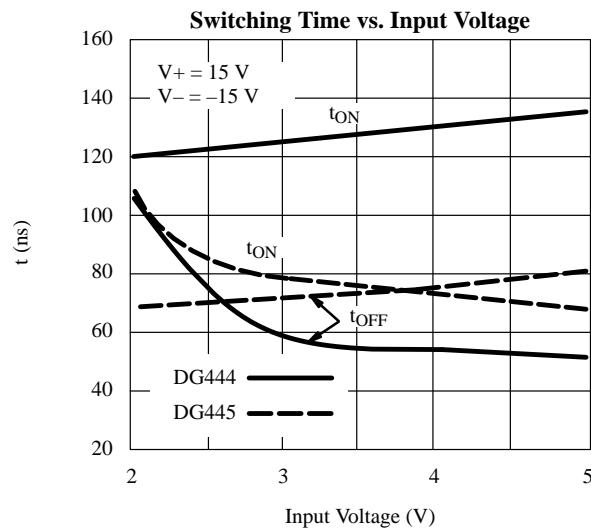
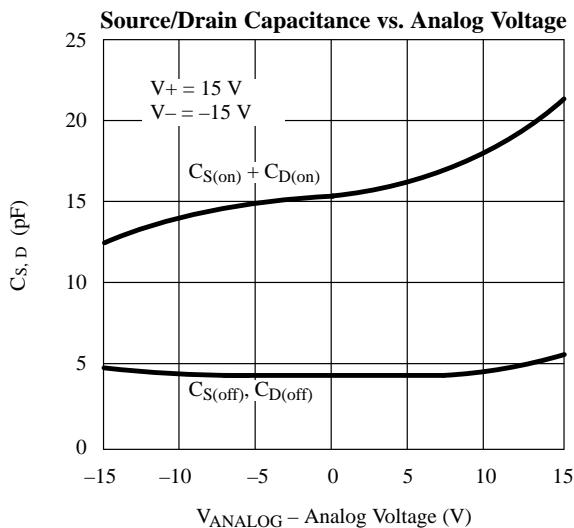
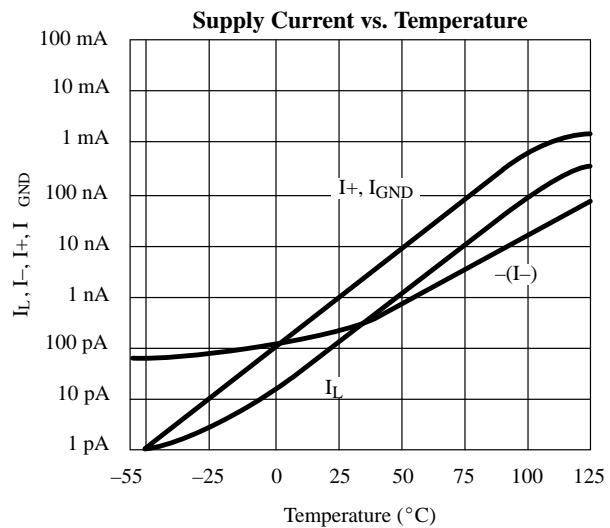
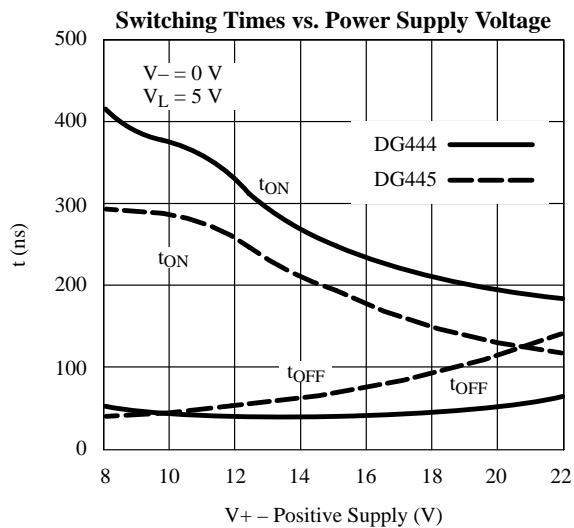
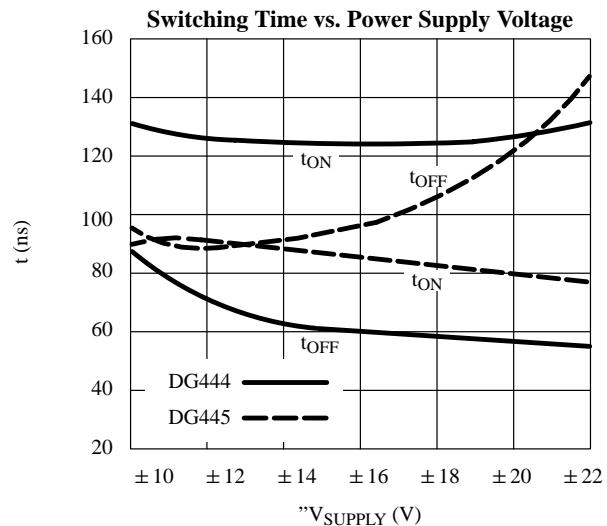
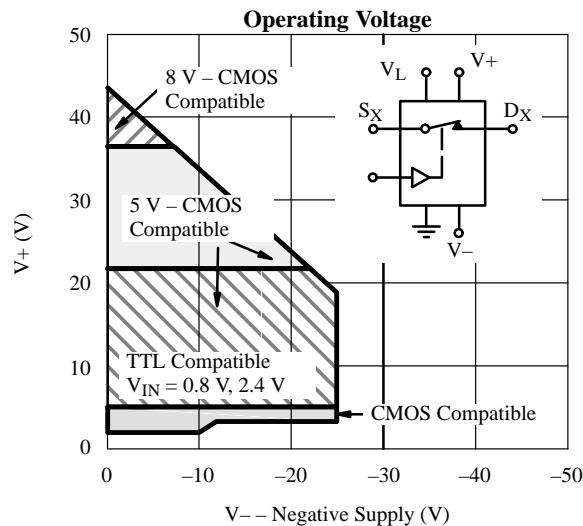
Notes:

- a. Room = 25°C, Full = as determined by the operating temperature suffix.
- b. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- c. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- d. Guaranteed by design, not subject to production test.
- e. V<sub>IN</sub> = input voltage to perform proper function.

### Typical Characteristics



## Typical Characteristics (Cont'd)



# DG444/445

TEMIC

Siliconix

## Schematic Diagram (Typical Channel)

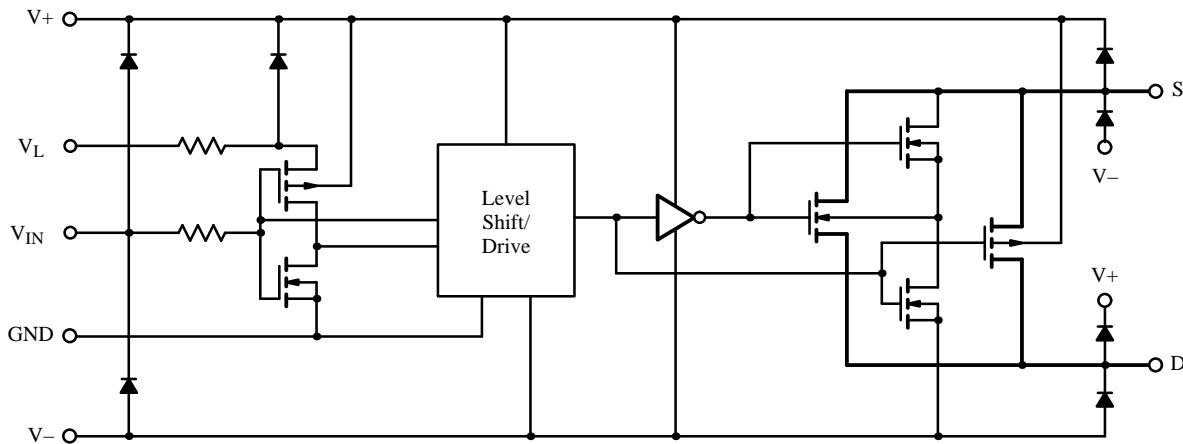
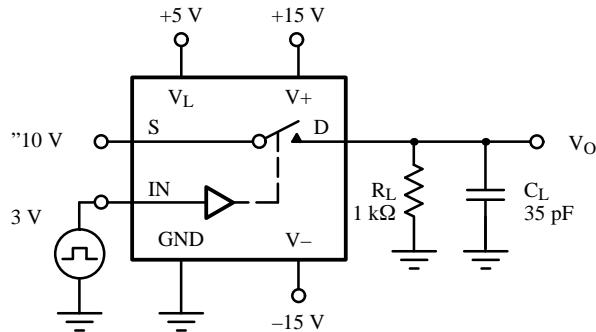
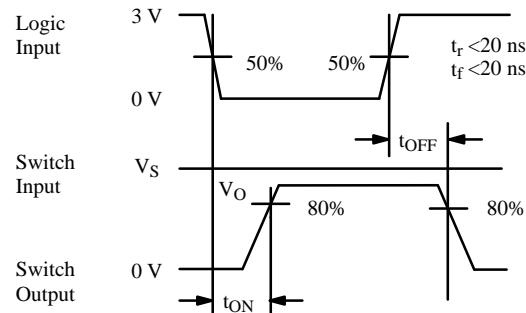


Figure 1.

## Test Circuits



$C_L$  (includes fixture and stray capacitance)



Note: Logic input waveform is inverted for DG445.

Figure 2. Switching Time

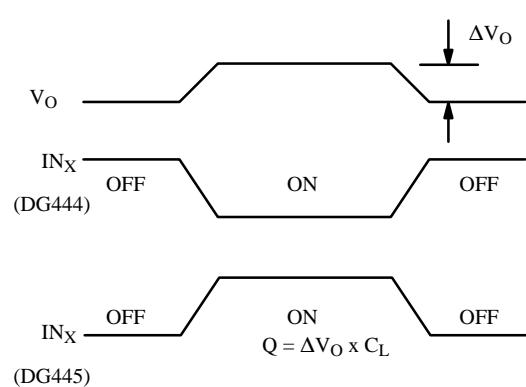
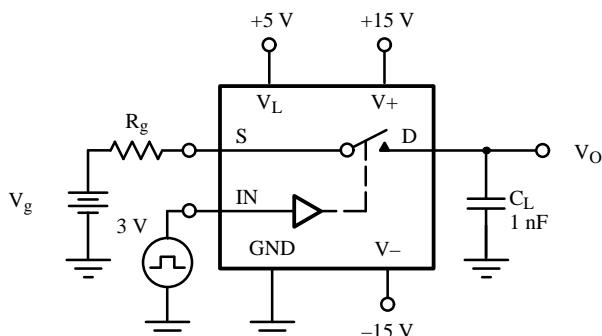


Figure 3. Charge Injection

## Test Circuits (Cont'd)

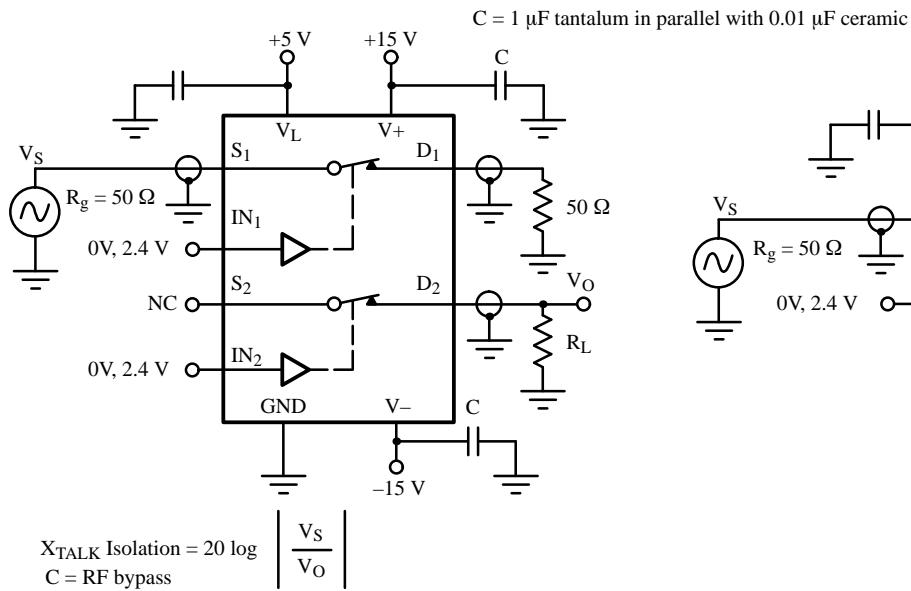


Figure 4. Crosstalk

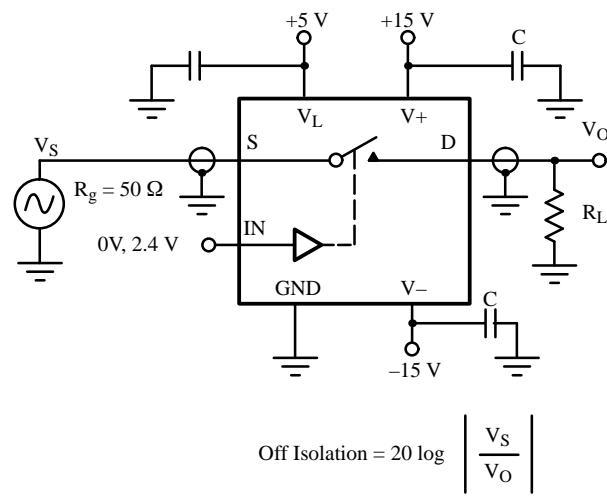


Figure 5. Off Isolation

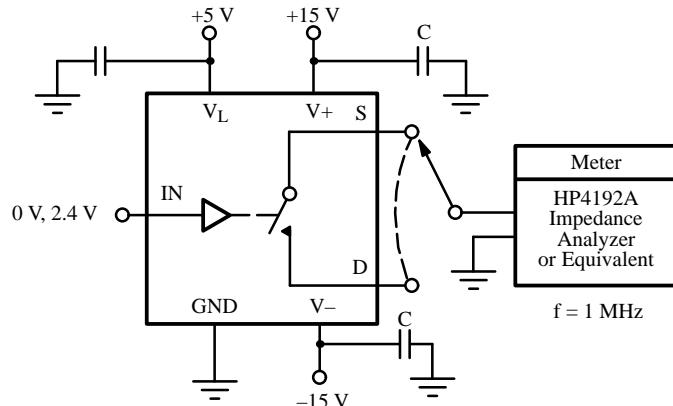


Figure 6. Source/Drain Capacitances

## Applications

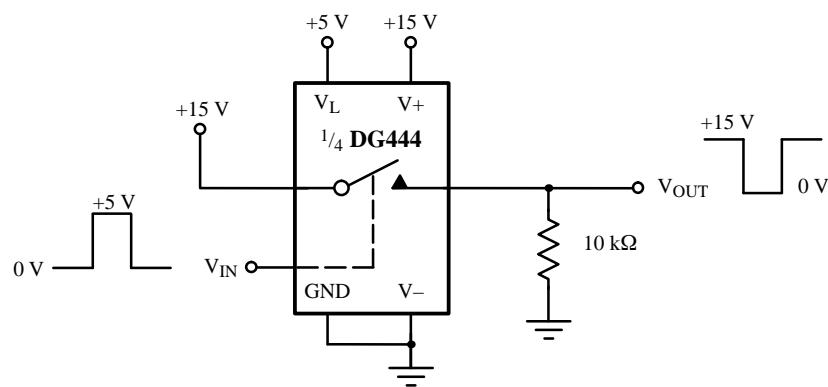


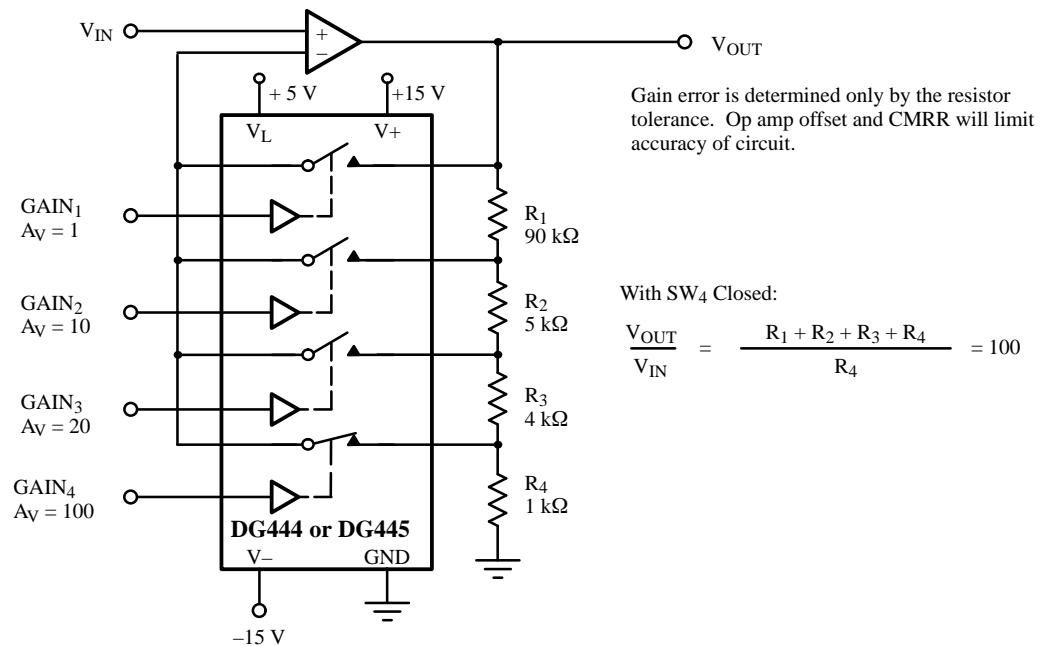
Figure 7. Level Shifter

# DG444/445

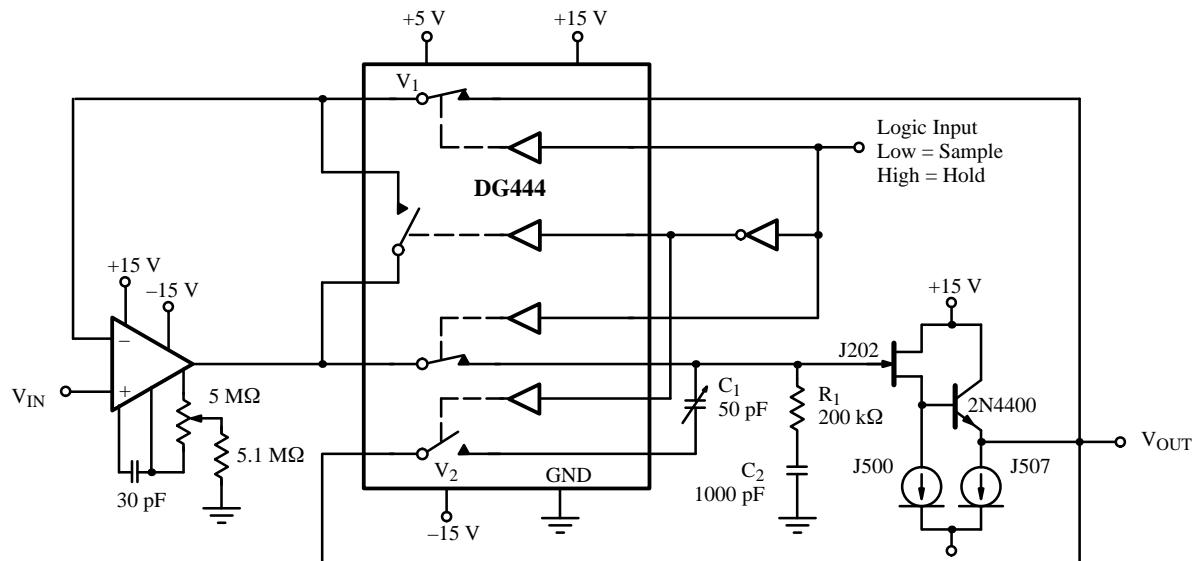
TEMIC

Siliconix

## Applications (Cont'd)



**Figure 8.** Precision-Weighted Resistor Programmable-Gain Amplifier



**Figure 9.** Precision Sample-and-Hold